

1733

Docket No.: GR 98 P 4137 P

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By:

Date: February 23, 2004

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No. : 09/761,594 Confirmation No: 5815
Applicant : Hans-Jürgen Hacke et al.
Filed : January 16, 2001
Title : Semiconductor Device in Chip Format and Method for Producing It
Art Unit : 1733
Examiner : John T. Haran

Docket No. : GR 98 P 4137 P
Customer No. : 24131

INFORMATION DISCLOSURE STATEMENT
UNDER 37 C.F.R. 1.97(C)(1)

Hon. Commissioner for Patents

Sir:

In accordance with 37 C.F.R. 1.98 copies of the following patents and/or publications are submitted herewith:

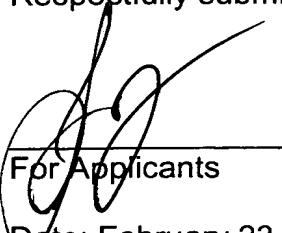
Japanese Patent Abstract JP 61 177 746 (Sugawara), dated August 9, 1986;

European Search Report dated January 8, 2004.

In accordance with 37 C.F.R. 1.97(e) the undersigned herewith states that each item of information contained in the information disclosure statement was first cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the information disclosure statement.

In accordance with 37 C.F.R. 1.97 (c) (1), consideration of this Information Disclosure Statement is requested.

Respectfully submitted,



Gregory L. Mayback
Reg. No. 40,719

For Applicants

Date: February 23, 2004

Lerner And Greenberg, P.A.
Post Office Box 2480
Hollywood, FL 33022-2480
Tel: (954) 925-1100
Fax: (954) 925-1101

/bmb



FORM PTO-1449 (SUBSTITUTE)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEINFORMATION DISCLOSURE
STATEMENT BY APPLICANT
(37 CFR 1.98(b))Attorney Docket No.:
GR 98 P 4137 PApplic. No.
09/761,594

Applicant

Hans-Jürgen Hacke et al.

Filing Date
January 16, 2001Group Art Unit
1733

U.S. PATENT DOCUMENTS

EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
	A						
	B						
	C						
	D						
	E						
	F						
	G						
	H						
	I						

FOREIGN PATENT DOCUMENT

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES NO
	J	61 177 746	08/09/86	Japan			X
	K						
	L						
	M						
	N						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

	O	
	P	

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609;
 Draw line through citation if not in conformance and not considered. Include copy of this form with
 next communication to applicant.